# UNISONIC TECHNOLOGIES CO., LTD

5N65-CQ **Preliminary Power MOSFET** 

# 5A, 650V N-CHANNEL **POWER MOSFET**

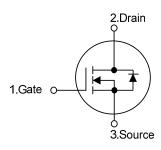
#### DESCRIPTION

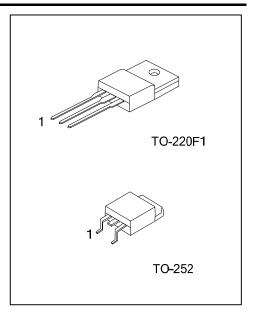
The UTC 5N65-CQ is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

#### **FEATURES**

- \*  $R_{DS(ON)}$  < 2.2  $\Omega$  @  $V_{GS}$  = 10 V,  $I_D$  = 2.5 A
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

#### **SYMBOL**

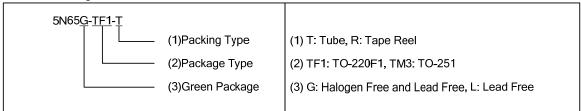




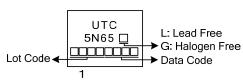
#### ORDERING INFORMATION

Ordering Number		Dookaga	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
5N65L-TF1-T	5N65G-TF1-T	TO-220F1	G	D	S	Tube	
5N65L-TN3-R	5N65G-TN3-R	TO-252	G	D	S	Tape Reel	

S: Source Note: Pin Assignment: G: Gate D: Drain



#### **MARKING**



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# ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	650	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Continuous Drain Current		$I_{D}$	5	Α	
Pulsed Drain Current (Note 2)		$I_{DM}$	20	Α	
Avalanche Energy	ergy Single Pulsed (Note 3)		64	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.4	V/ns	
Power Dissipation	TO-220F1	D	36	W	
	TO-252	$P_D$	54	W	
Junction Temperature		T <sub>J</sub>	+150	°C	
Storage Temperature		$T_{STG}$	-55 ~ <b>+</b> 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 16mH,  $I_{AS}$  = 2.82A,  $V_{DD}$  = 50V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C
- 4.  $I_{SD} \le 5.0$ A, di/dt  $\le 200$ A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25$ °C

### **■ THERMAL DATA**

PARAMETER		SYMBOL	RATING	UNIT	
Junction to Ambient	TO-220F1	0	62.5	°C/W	
	TO-252	$\theta_{JA}$	160		
Junction to Case	TO-220F1	0	3.47	°C/W	
	TO-252	$\theta_{JC}$	2.3	C/VV	



## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> =25°C, unless otherwise specified)

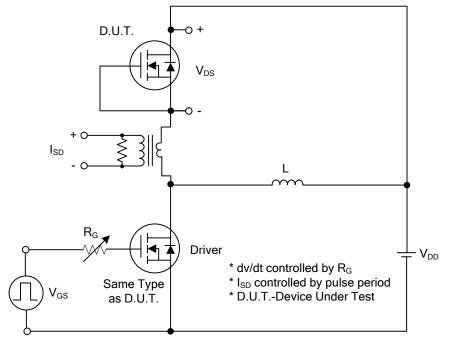
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	$V_{GS} = 0V, I_D = 250\mu A$	650			V
Drain-Source Leakage Current		I <sub>DSS</sub>	$V_{DS} = 650V, V_{GS} = 0V$			10	μΑ
Gate- Source Leakage Current	Forward		$V_{GS} = 30V, V_{DS} = 0V$			100	nA
	Reverse	$I_{GSS}$	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	$V_{GS} = 10V, I_D = 2.5A$			2.2	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C <sub>ISS</sub>	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V,		528		pF
Output Capacitance		Coss	f=1.0 MHz		70		pF
Reverse Transfer Capacitance		$C_{RSS}$	1-1.0 1/11 12		9		pF
SWITCHING CHARACTERISTICS	S						
Total Gate Charge		$Q_G$	\\ _50\\ \\ _40\\   _40\		46		nC
Gate-Source Charge		$Q_GS$	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>D</sub> =1.3A, I <sub>D</sub> =100µA (Note 1, 2)		4.2		nC
Gate-Drain Charge		$Q_GD$	ΠΔ-100μΑ (Note 1, 2)		7		nC
Turn-On Delay Time		$t_{D(ON)}$			46		ns
Turn-On Rise Time		$t_R$	$V_{DD}$ =30V, $V_{GS}$ =10V, $I_{D}$ =0.5A,		50		ns
Turn-Off Delay Time		t <sub>D(OFF)</sub>	$R_G = 25\Omega$ (Note 1, 2)		160		ns
Turn-Off Fall Time		$t_{F}$			46		ns
DRAIN-SOURCE DIODE CHARA	CTERISTIC	CS AND MAXII	MUM RATINGS				
Maximum Continuous Drain-Source Diode		I <sub>S</sub>				5	Α
Forward Current						3	^
Maximum Pulsed Drain-Source Diode		I <sub>SM</sub>				20	Α
Forward Current						20	^
Drain-Source Diode Forward Voltage		$V_{SD}$	I <sub>S</sub> =5.0A , V <sub>GS</sub> =0V			1.4	V
Body Diode Reverse Recovery Time		t <sub>rr</sub>	I <sub>S</sub> =5.0A , V <sub>GS</sub> =0V		264		ns
Body Diode Reverse Recovery Charge		$Q_{rr}$	di/dt=100A/μs		1.62		μC

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

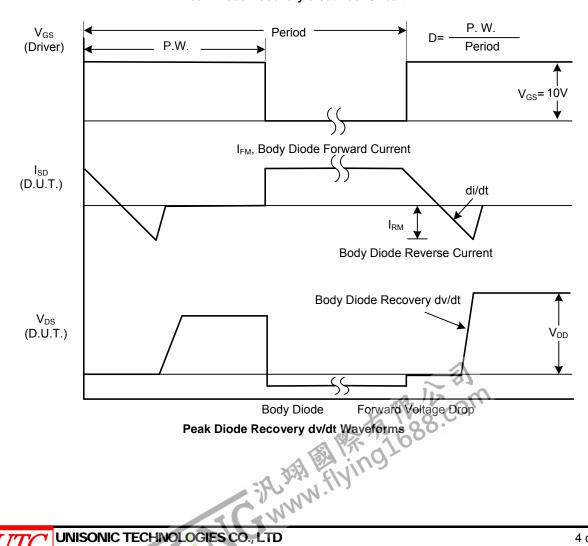


<sup>2.</sup> Essentially independent of operating temperature

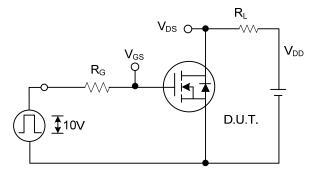
#### **TEST CIRCUITS AND WAVEFORMS**



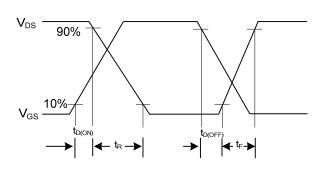
Peak Diode Recovery dv/dt Test Circuit



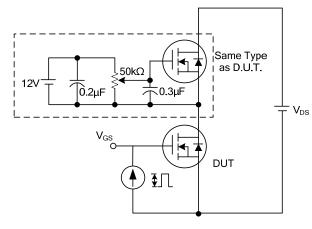
# ■ TEST CIRCUITS AND WAVEFORMS (Cont.)



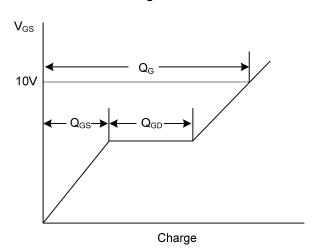
**Switching Test Circuit** 



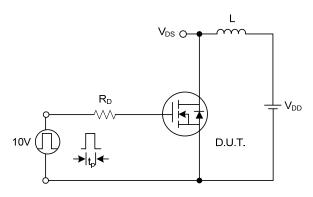
**Switching Waveforms** 



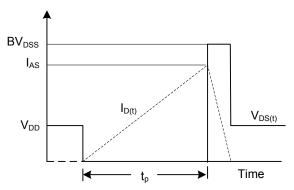
**Gate Charge Test Circuit** 



**Gate Charge Waveform** 



**Unclamped Inductive Switching Test Circuit** 



**Unclamped Inductive Switching Waveforms** 

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